

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π -MOSIII)

2SK3301

HIGH SPEED, HIGH VOLTAGE SWITCHING APPLICATIONS
SWITCHING REGULATOR, DC-DC CONVERTER APPLICATIONS

INDUSTRIAL APPLICATIONS
Unit in mm

- Low Drain-Source ON Resistance : $R_{DS(ON)} = 15 \Omega$ (Typ.)
- High Forward Transfer Admittance : $|Y_{fs}| = 0.65 S$ (Typ.)
- Low Leakage Current : $I_{DSS} = 100 \mu A$ (Max.) ($V_{DS} = 720 V$)
- Enhancement-Mode : $V_{th} = 2.4 \sim 3.4 V$
($V_{DS} = 10 V, I_D = 1 mA$)

MAXIMUM RATINGS ($T_a = 25^\circ C$)

| CHARACTERISTIC | SYMBOL | RATING | UNIT |
|--|-----------|----------------|------------|
| Drain-Source Voltage | V_{DSS} | 900 | V |
| Drain-Gate Voltage ($R_{GS} = 20 k\Omega$) | V_{DGR} | 900 | V |
| Gate-Source Voltage | V_{GSS} | ± 30 | V |
| DC Drain Current | DC | I_D | 1 A |
| | Pulse | I_{DP} | 2 A |
| Drain Power Dissipation ($T_a = 25^\circ C$) | P_D | 20 | W |
| Single Pulse Avalanche Energy** | E_{AS} | 140 | mJ |
| Avalanche Current | I_{AR} | 1 | A |
| Repetitive Avalanche Energy* | E_{AR} | 2.0 | mJ |
| Channel Temperature | T_{ch} | 150 | $^\circ C$ |
| Storage Temperature Range | T_{stg} | $-55 \sim 150$ | $^\circ C$ |

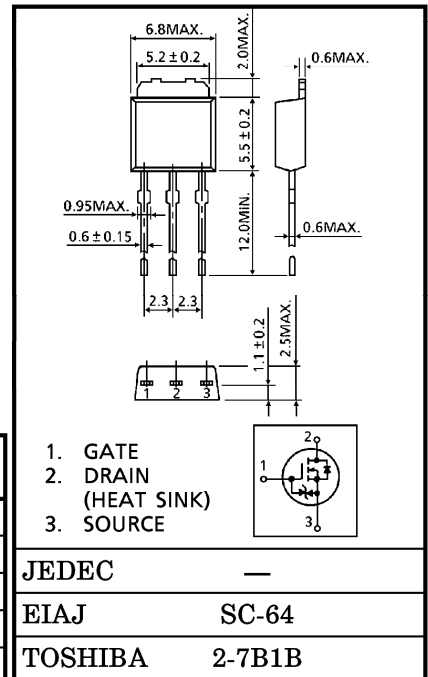
THERMAL CHARACTERISTICS

| CHARACTERISTIC | SYMBOL | MAX. | UNIT |
|--|----------------|------|--------------|
| Thermal Resistance, Channel to Case | $R_{th(ch-c)}$ | 6.25 | $^\circ C/W$ |
| Thermal Resistance, Channel to Ambient | $R_{th(ch-a)}$ | 125 | $^\circ C/W$ |

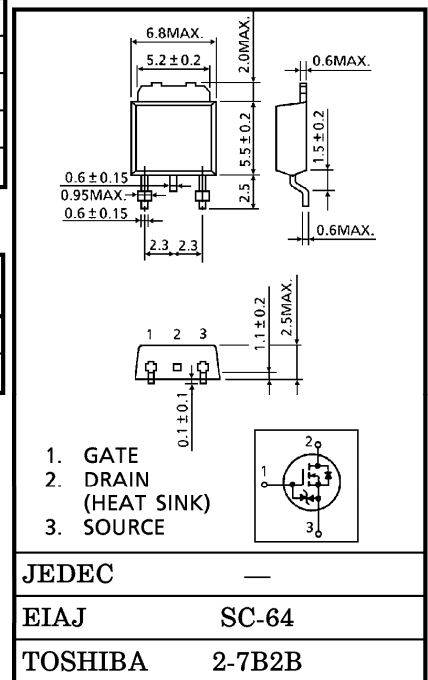
Note ;

- * Repetitive rating ; Pulse Width Limited by Max. junction temperature.
- ** $V_{DD} = 90 V, T_{ch} = 25^\circ C$ (initial), $L = 257 mH$
 $R_G = 25 \Omega, I_{AR} = 1 A$

**This transistor is an electrostatic sensitive device.
Please handle with caution.**



Weight : 0.36g



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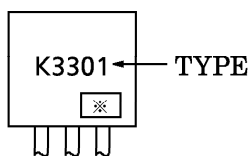
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC | | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|---|---------------|---------------|---|--|------|----------|---------------|
| Gate Leakage Current | | I_{GSS} | $V_{GS} = \pm 30\text{ V}, V_{DS} = 0\text{ V}$ | — | — | ± 10 | μA |
| Gate-Source Breakdown Voltage | | $V_{(BR)GSS}$ | $I_G = \pm 10\ \mu\text{A}, V_{DS} = 0\text{ V}$ | ± 30 | — | — | V |
| Drain Cut-off Current | | I_{DSS} | $V_{DS} = 720\text{ V}, V_{GS} = 0\text{ V}$ | — | — | 100 | μA |
| Drain-Source Breakdown Voltage | | $V_{(BR)DSS}$ | $I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$ | 900 | — | — | V |
| Gate Threshold Voltage | | V_{th} | $V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$ | 2.4 | — | 3.4 | V |
| Drain-Source ON Resistance | | $R_{DS(ON)}$ | $V_{GS} = 10\text{ V}, I_D = 0.5\text{ A}$ | — | 15 | 20 | Ω |
| Forward Transfer Admittance | | $ Y_{fs} $ | $V_{DS} = 10\text{ V}, I_D = 0.5\text{ A}$ | 0.3 | 0.65 | — | S |
| Input Capacitance | | C_{iss} | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $f = 1\text{ MHz}$ | — | 165 | — | pF |
| Reverse Transfer Capacitance | | C_{rss} | | — | 6 | — | |
| Output Capacitance | | C_{oss} | | — | 21 | — | |
| Switching Time | Rise Time | t_r | | — | 15 | — | ns |
| | Turn-on Time | t_{on} | | — | 60 | — | |
| | Fall Time | t_f | | — | 40 | — | |
| | Turn-off Time | t_{off} | | $V_{IN} : t_r, t_f < 5\text{ ns},$ $Duty \leq 1\%, t_w = 10\ \mu\text{s}$ | — | 110 | |
| Total Gate Charge (Gate-Source Plus Gate-Drain) | | Q_g | $V_{DD} \doteq 400\text{ V}, V_{GS} = 10\text{ V},$ $I_D = 1\text{ A}$ | — | 6 | — | nC |
| Gate-Source Charge | | Q_{gs} | | — | 3 | — | |
| Gate-Drain ("Miller") Charge | | Q_{gd} | | — | 3 | — | |

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|----------------------------------|-----------|---|------|------|------|---------------|
| Continuous Drain Reverse Current | I_{DR} | — | — | — | 1 | A |
| Pulse Drain Reverse Current | I_{DRP} | — | — | — | 2 | A |
| Diode Forward Voltage | V_{DSF} | $I_{DR} = 1\text{ A}, V_{GS} = 0\text{ V}$ | — | — | -1.7 | V |
| Reverse Recovery Time | t_{rr} | $I_{DR} = 1\text{ A}, V_{GS} = 0\text{ V}$ | — | 1300 | — | ns |
| Reverse Recovery Charge | Q_{rr} | $dI_{DR} / dt = 100\text{ A} / \mu\text{s}$ | — | 1.95 | — | μC |

MARKING



※ Lot Number

□ □ — Month (Starting from Alphabet A)

— Year (Last Number of the Christian Era)